# SONY

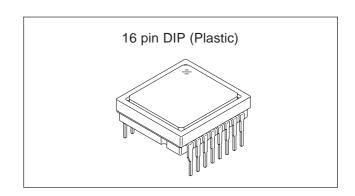
# ICX424AL

# Diagonal 6mm (Type 1/3) Progressive Scan CCD Solid-state Image Sensor with Square Pixel for B/W Cameras

# **Description**

The ICX424AL is a diagonal 6mm (Type 1/3) interline CCD solid-state image sensor with a square pixel array suitable for EIA black-and-white cameras. Progressive scan allows all pixel's signals to be output independently within approximately 1/60 second. This chip features an electronic shutter with variable charge-storage time which makes it possible to realize full-frame still images without a mechanical shutter. High sensitivity and low dark current are achieved through the adoption of the HAD (Hole-Accumulation Diode) sensors.

This chip is suitable for applications such as FA and surveillance cameras.



#### **Features**

- Progressive scan allows individual readout of the image signals from all pixels.
- High vertical resolution (480 TV-lines) still images without a mechanical shutter
- Square pixel
- Supports VGA format
- Horizontal drive frequency: 24.54MHz
- No voltage adjustments (reset gate and substrate bias are not adjusted.)
- · High resolution, high sensitivity, low dark current
- Continuous variable-speed shutter
- · Low smear
- · Excellent anti-blooming characteristics
- Horizontal register: 5.0V drive
- 16-pin high precision plastic package (enables dual-surface standard)

# 

Optical black position (Top View)

# **Device Structure**

Interline CCD image sensor

• Image size: Diagonal 6mm (Type 1/3)

• Number of effective pixels: 659 (H)  $\times$  494 (V) approx. 330K pixels • Total number of pixels: 692 (H)  $\times$  504 (V) approx. 350K pixels

• Chip size: 5.79mm (H)  $\times$  4.89mm (V) • Unit cell size: 7.4 $\mu$ m (H)  $\times$  7.4 $\mu$ m (V)

Optical black: Horizontal (H) direction: Front 2 pixels, rear 31 pixels

Vertical (V) direction: Front 8 pixels, rear 2 pixels

Number of dummy bits: Horizontal 16

Vertical 5

Substrate material: Silicon

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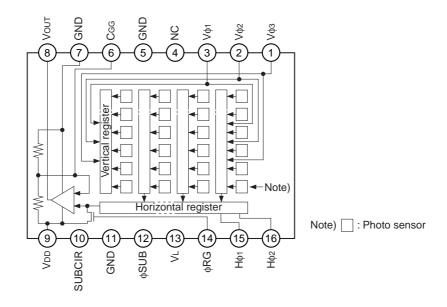
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# **Block Diagram and Pin Configuration**

(Top View)



# **Pin Description**

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	Vфз	Vertical register transfer clock	9	VDD	Supply voltage
2	Vф2	Vertical register transfer clock	10	SUBCIR	Supply voltage for the substrate voltage generation
3	Vф1	Vertical register transfer clock	11	GND	GND
4	NC		12	φSUB	Substrate clock
5	GND	GND	13	VL	Protective transistor bias
6	Cgg	Output amplifier gate*1	14	φRG	Reset gate clock
7	GND	GND	15	Нф1	Horizontal register transfer clock
8	Vouт	Signal output	16	Нф2	Horizontal register transfer clock

<sup>\*1</sup> DC bias is applied within the CCD, so that this pin should be grounded externally through a capacitance of 1000pF.

# **Absolute Maximum Ratings**

	Item	Ratings	Unit	Remarks
Substrate clock	B – GND	-0.3 to +36	V	
Supply voltage	Vdd, Vout, Cgg, SUBCIR – GND	-0.3 to +18	V	
Cappiy rollage	Vdd, Vout, Cgg, SUBCIR – фSUB	-22 to +9	V	
Clock input voltage	Vφ1, Vφ2, Vφ3 – GND	-15 to +16	V	
- Cicon input voltage	Vφ1, Vφ2, Vφ3 – φSUB	to +10	V	
Voltage difference be	tween vertical clock input pins	to +15	V	*2
Voltage difference be	tween horizongal clock input pins	to +16	V	
Hφ1, Hφ2 – Vφ3		-16 to +16	V	
Hφ1, Hφ2 – GND		-10 to +15	V	
Hφ1, Hφ2 − φSUB		-55 to +10	V	
VL – ¢SUB		-65 to +0.3	V	
Vφ2, Vφ3 – VL		-0.3 to +27.5	V	
RG – GND		-0.3 to +20.5	V	
Vφ1, Hφ1, Hφ2, GND -	- VL	-0.3 to +17.5	V	
Storage temperature		-30 to +80	°C	
Performance guarant	ee temperature	-10 to +60	°C	
Operating temperatur	re	-10 to +75	°C	

 $<sup>^{*2}</sup>$  +24V (Max.) when clock width < 10 $\mu$ s, clock duty factor < 0.1%.

<sup>+16</sup>V (Max.) is guaranteed for power-on and power-off.

# **Bias Conditions**

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Supply voltage	VDD	14.55	15.0	15.45	V	
Protective transistor bias	VL		*1	•		
Substrate clock	φSUB		*2			
Reset gate clock	φRG		*3			

<sup>\*1</sup> VL setting is the VvL voltage of the vertical transfer clock waveform, or the same voltage as the VL power supply for the V driver should be used.

# **DC Characteristics**

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Supply current	IDD		7	9	mA	

# **Clock Voltage Conditions**

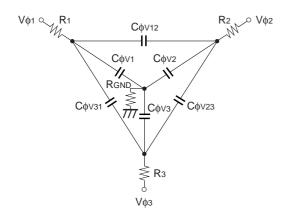
Item	Symbol	Min.	Тур.	Max.	Unit	Waveform Diagram	Remarks
Readout clock voltage	Vvт	14.55	15.0	15.45	V	1	
	VvH02	-0.05	0	0.05	V	2	Vvh = Vvh02
	Vvh1, Vvh2, Vvh3	-0.2	0	0.05	V	2	
	VVL1, VVL2, VVL3	-7.8	-7.5	-7.2	V	2	VvL = VvL1 (VvL3)/2 (During 24.54MHz)
Vertical transfer clock	Vvl1, Vvl2, Vvl3	-8.0	-7.5	-7.0	V	2	VvL = VvL1 (VvL3)/2 (During 12.27MHz)
voltage	Vφ1, Vφ2, Vφ3	6.8	7.5	8.05	V	2	
	Vvl1 — Vvl3			0.1	V	2	
	Vvнн			1.0	V	2	High-level coupling
	Vvhl			2.3	V	2	High-level coupling
	Vvlh			1.0	V	2	Low-level coupling
	Vvll			1.0	V	2	Low-level coupling
	Vфн	4.75	5.0	5.25	V	3	
Horizontal transfer clock voltage	VHL	-0.05	0	0.05	V	3	
olook voltago	Vcr	0.8	2.5		V	3	Cross-point voltage
	V¢RG	4.5	5.0	5.5	V	4	
Reset gate clock voltage	Vrglh – Vrgll			0.8	V	4	Low-level coupling
Vollago	VRGL — VRGLm			0.5	V	4	Low-level coupling
Substrate clock voltage	Vфsuв	21.5	22.5	23.5	V	5	

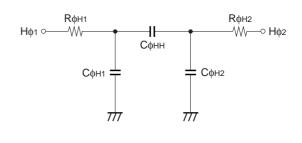
 $<sup>^{*2}</sup>$  Set SUBCIR pin to open when applying a DC bias to the substrate clock pin.

<sup>\*3</sup> Do not apply a DC bias to the reset gate clock pins, because a DC bias is generated within the CCD.

# **Clock Equivalent Circuit Constants**

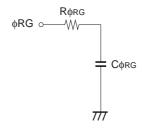
Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
	Сф∨1		3900		pF	
Capacitance between vertical transfer clock and GND	Сф∨2		3300		pF	
	Сф∨з		3300		pF	
	СфV12		1000		pF	
Capacitance between vertical transfer clocks	Сф∨23		1000		pF	
	Сф∨31		1000		pF	
Capacitance between horizontal transfer clock and GND	Сфн1, Сфн2		47		pF	
Capacitance between horizontal transfer clocks	Сфнн		30		pF	
Capacitance between reset gate clock and GND	Сфяс		6		pF	
Capacitance between substrate clock and GND	Сфѕив		560		pF	
Ventical transfer also le series resistes	R1, R2		33		Ω	
Vertical transfer clock series resistor	R <sub>3</sub>		18		Ω	
Vertical transfer clock ground resistor	RGND		100		Ω	
Horizontal transfer clock series resistor	Rфн1, Rфн2		10		Ω	
Reset gate clock series resistor	Rørg		39		Ω	





Vertical transfer clock equivalent circuit

Horizontal transfer clock equivalent circuit



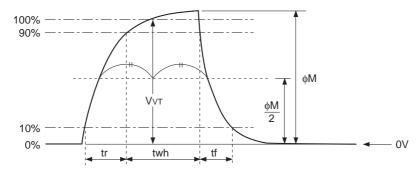
Reset gate clock equivalent circuit

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# **Drive Clock Waveform Conditions**

# (1) Readout clock waveform

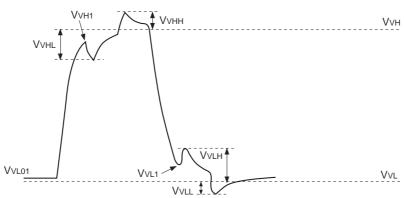




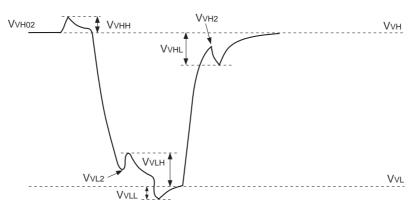
Note) Readout clock is used by composing vertical transfer clocks  $V\phi_2$  and  $V\phi_3.$ 

# (2) Vertical transfer clock waveform

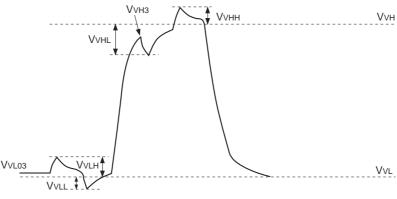
 $V\varphi_1$ 



Vф2

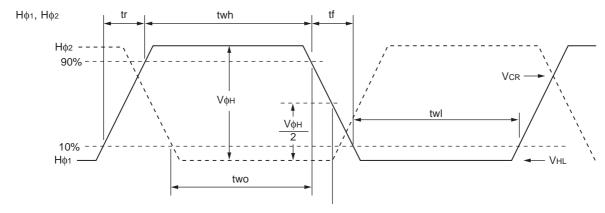


Vфз



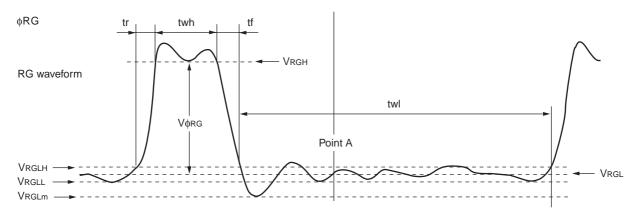
VVH = VVH02 VVL = (VVL01 + VVL03)/2 VVL3 = VVL03  $\begin{array}{c} V\phi v_1 = Vv H_1 - Vv L_{01} \\ V\phi v_2 = Vv H_{02} - Vv L_{2} \\ -7 - V\phi v_3 = Vv H_{3} - Vv L_{03} \end{array}$ 

# (3) Horizontal transfer clock waveform



Cross-point voltage for the H $\phi_1$  rising side of the horizontal transfer clocks H $\phi_1$  and H $\phi_2$  waveforms is Vcr. The overlap period for twh and twl of horizontal transfer clocks H $\phi_1$  and H $\phi_2$  is two.

# (4) Reset gate clock waveform



VRGLH is the maximum value and VRGLL is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG.

In addition, VRGL is the average value of VRGLH and VRGLL.

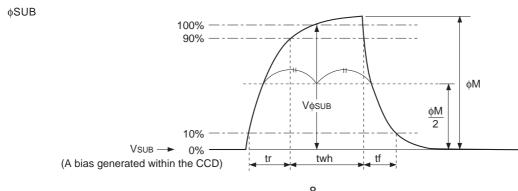
$$V_{RGL} = (V_{RGLH} + V_{RGLL})/2$$

Assuming VRGH is the minimum value during the interval twh, then:

$$V\phi RG = VRGH - VRGL$$

Negative overshoot level during the falling edge of RG is VRGLm.

# (5) Substrate clock waveform



# Clock Switching Characteristics (Horizontal drive frequency: 24.54MHz)

14	Itam Symbol		twh			twl			tr			tf		1.1:4	Damanla
Item	Symbol	Min.	Тур.	Мах.	Min.	Тур.	Мах.	Min.	Тур.	Max.	Min.	Тур.	Мах.	Unit	Remarks
Readout clock	VT	2.3	2.5						0.5			0.5		μs	During readout
Vertical transfer clock	Vφ1, Vφ2, Vφ3										15		250	ns	When using CXD3400N
Horizontal	Нф1	10.5	14.6		10.5	14.6			6.4	10.5		6.4	10.5	20	46 > 411 - 0110
transfer clock	Нф2	10.5	14.6		10.5	14.6			6.4	10.5		6.4	10.5	ns	tf ≥ tr – 2ns
Reset gate clock	φRG	6	8			25.8			4			3		ns	
Substrate clock	φSUB	0.75	0.9							0.5			0.5	μs	When draining charge

lto an	Curahal	two			المنادا	Domarks	
Item	Symbol	Min.	Тур.	Мах.	Unit	Remarks	
Horizontal transfer clock	<b>Н</b> ф1, <b>Н</b> ф2	10.5	14.6		ns	*1	

# Clock Switching Characteristics (Horizontal drive frequency: 12.27MHz)

li	0		twh			twl			tr			tf		11.20	Devedo
Item	Symbol	Min.	Тур.	Мах.	Unit	Remarks									
Readout clock	VT	4.6	5.0						0.5			0.5		μs	During readout
Vertical transfer clock	Vφ1, Vφ2, Vφ3										15		350	ns	When using CXD3400N
Horizontal	Нф1	24	30		25	31.5			10	17.5		10	17.5		# > + = O = =
transfer clock	Нф2	26.5	31.5		25	30			10	15		10	15	ns	tf ≥ tr – 2ns
Reset gate clock	φRG	11	13			62.5			3			3		ns	
Substrate clock	φSUB	1.5	1.8							0.5			0.5	μs	When draining charge

Itom	Cumbal	two		l lmit	Domorko	
ltem	Symbol	Min. Typ	Max.	Unit	Remarks	
Horizontal transfer clock	Нф1, Нф2	21.5 25.	5	ns	*1	

<sup>\*1</sup> The overlap period of twh and twl of horizontal transfer clocks  $H\phi_1$  and  $H\phi_2$  is two.

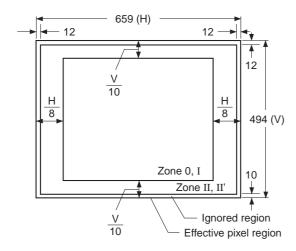
# **Image Sensor Characteristics**

 $(Ta = 25^{\circ}C)$ 

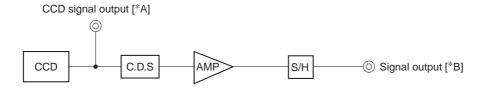
Item	Symbol	Min.	Тур.	Max.	Unit	Measurement method	Remarks
Sensitivity	S	700	880		mV	1	1/30s accumulation conversion value
Saturation signal	Vsat	500			mV	2	Ta = 60°C
Smear	Sm		-100	-92	dB	3	
Video signal shading	SH			20	%	4	Zone 0, I
Video signal shading	ЗП			25	%	4	Zone 0 to II'
Dark signal	Vdt			2	mV	5	Ta = 60°C
Dark signal shading	ΔVdt			0.5	mV	6	Ta = 60°C
Lag	Lag			0.5	%	7	

Note) All image sensor characteristic data noted above is for operation in 1/60s progressive scan mode.

# **Zone Definition of Video Signal Shading**



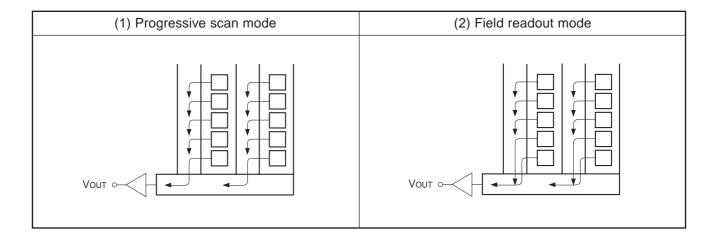
# **Measurement System**



**Note)** Adjust the amplifier gain so that the gain between [\*A] and [\*B] equals 1.

# Image sensor readout mode

The diagram below shows the output methods for the following three readout modes.



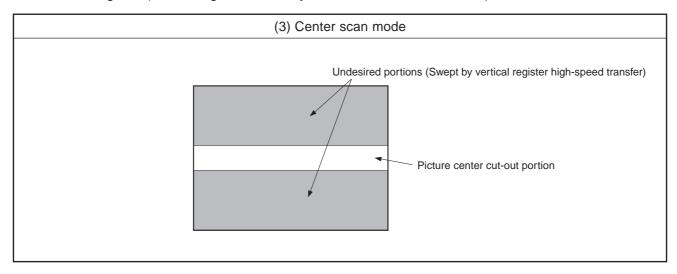
# 1. Progressive scan mode

In this mode, all pixel signals are output in non-interlace format in 1/60s.

All pixel signals within the same exposure period are read out simultaneously, making this mode suitable for high resolution image capturing.

#### 2. Field readout mode

All pixels are readout, 2-line transfer is performed during H blanking period and 2 pixels are added by horizontal register. (However, guarantees only at the time of a 12MHz drive.)



# 3. Center scan mode

This is the center scan mode using the progressive scan method.

The undesired portions are swept by vertical register high-speed transfer, and the picture center portion is cut out.

There are the mode (120 frames/s) which outputs 222 lines of an output line portion, and the mode (240 frames/s) which outputs 76 lines.

# **Image Sensor Characteristics Measurement Method**

#### Measurement conditions

(1) In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions.

(2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value measured at point [\*B] of the measurement system.

#### Definition of standard imaging conditions

#### (1) Standard imaging condition I:

Use a pattern box (luminance: 706cd/m², color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F8. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

# (2) Standard imaging condition II:

Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

#### 1. Sensitivity

Set to standard imaging condition I. After setting the electronic shutter mode with a shutter speed of 1/250s, measure the signal voltage (Vs) at the center of the screen, and substitute the value into the following formula.

$$S = Vs \times \frac{250}{30} [mV]$$

#### 2. Saturation signal

Set to standard imaging condition II. After adjusting the luminous intensity to 10 times the intensity with the average value of the signal output, 150mV, measure the minimum value of the signal output.

#### 3. Smear

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, first adjust the luminous intensity to 500 times the intensity with the average value of signal output, 150mV. Then after the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (VSm [mV]) of the signal output and substitute the value into the following formula.

$$Sm = 20 \times log \left( \frac{VSm}{150} \times \frac{1}{500} \times \frac{1}{10} \right) \text{ [dB] (1/10V method conversion value)}$$

#### 4. Video signal shading

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the signal output is 150mV. Then measure the maximum (Vmax [mV]) and minimum (Vmin [mV]) values of the signal output and substitute the values into the following formula.

$$SH = (Vmax - Vmin)/150 \times 100 [\%]$$

# 5. Dark signal

Measure the average value of the signal output (Vdt [mV]) with the device ambient temperature 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

# 6. Dark signal shading

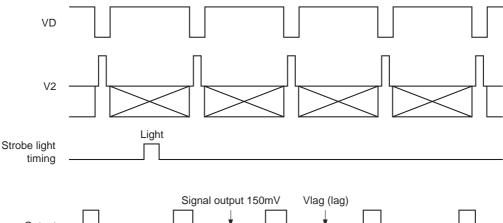
After measuring 5, measure the maximum (Vdmax [mV]) and minimum (Vdmin [mV]) values of the dark signal output and substitute the values into the following formula.

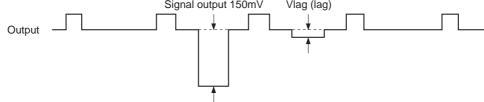
$$\Delta Vdt = Vdmax - Vdmin [mV]$$

# 7. Lag

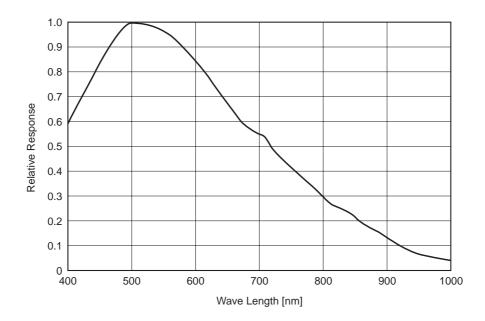
Adjust the signal output generated by strobe light to 150mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal (Vlag). Substitute the value into the following formula.

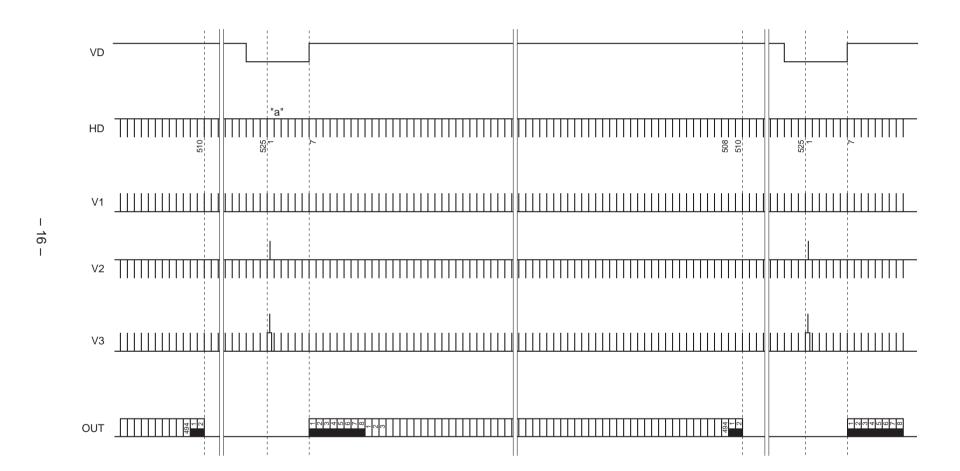
Lag = 
$$(Vlag/150) \times 100 [\%]$$



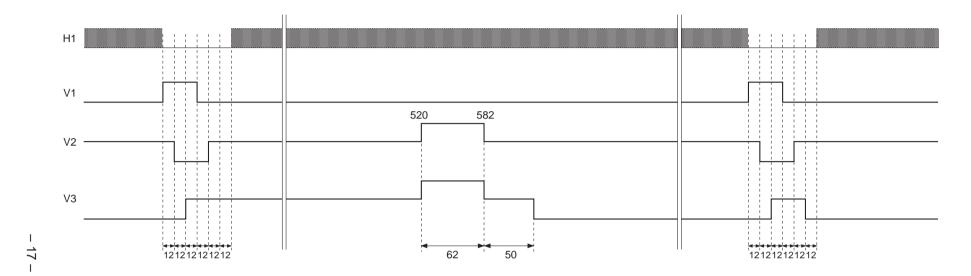


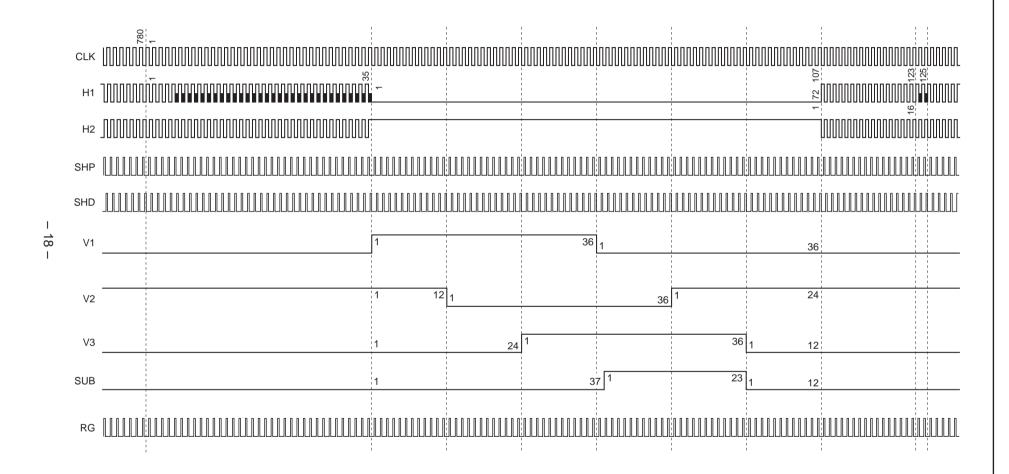
Spectral Sensitivity Characteristics (Excludes lens characteristics and light source characteristics)

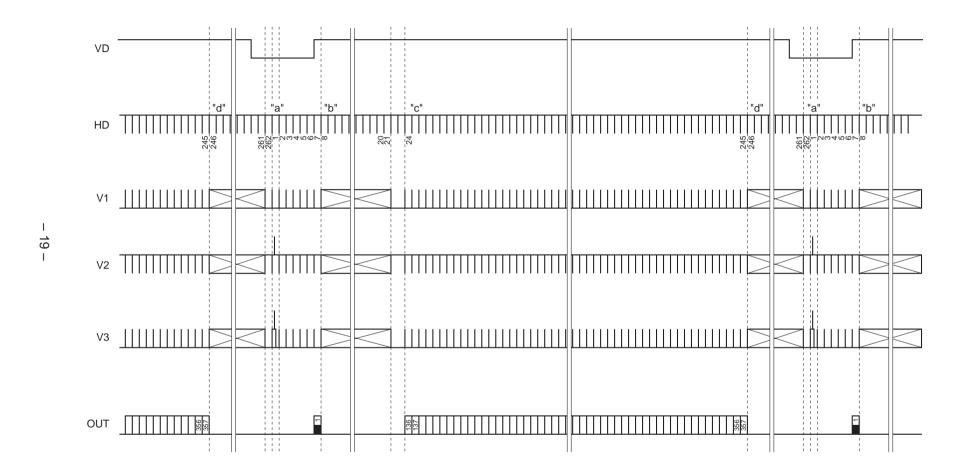


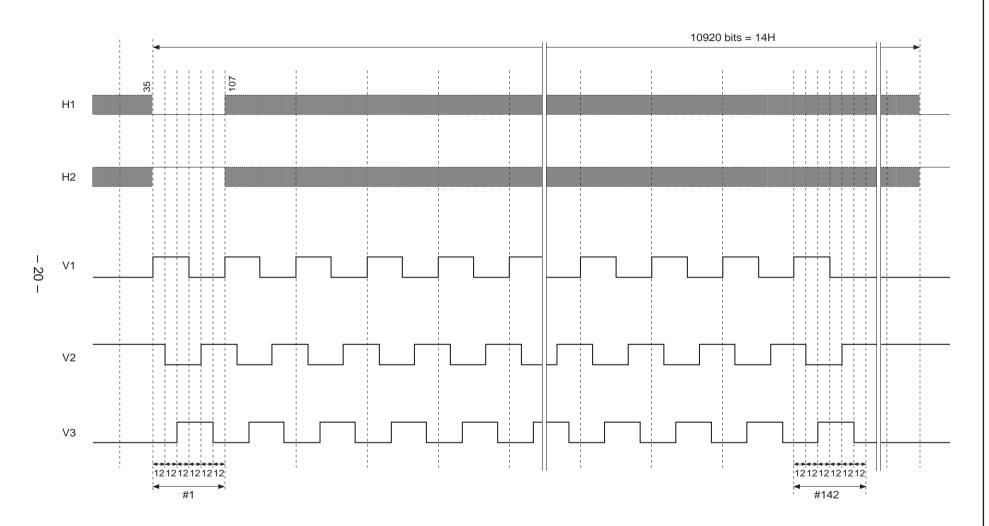


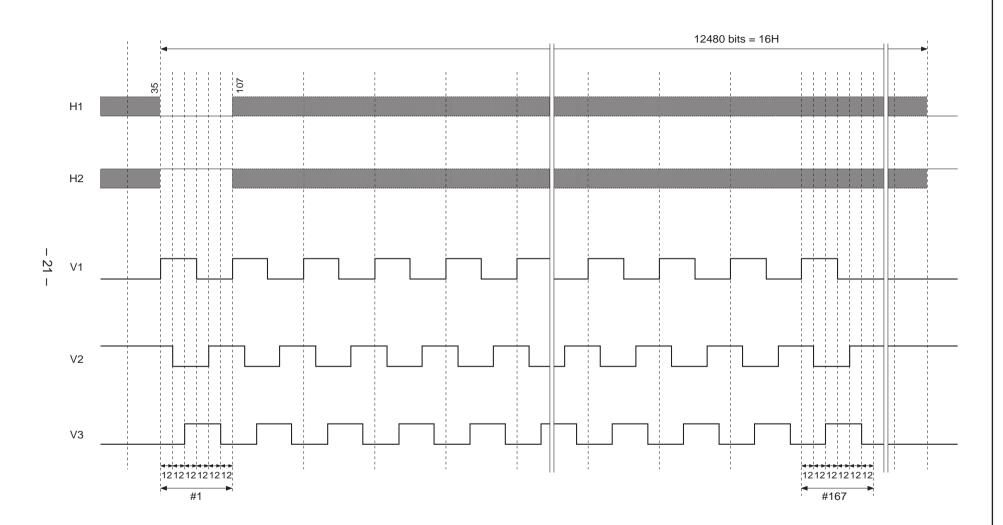
"a" Enlarged

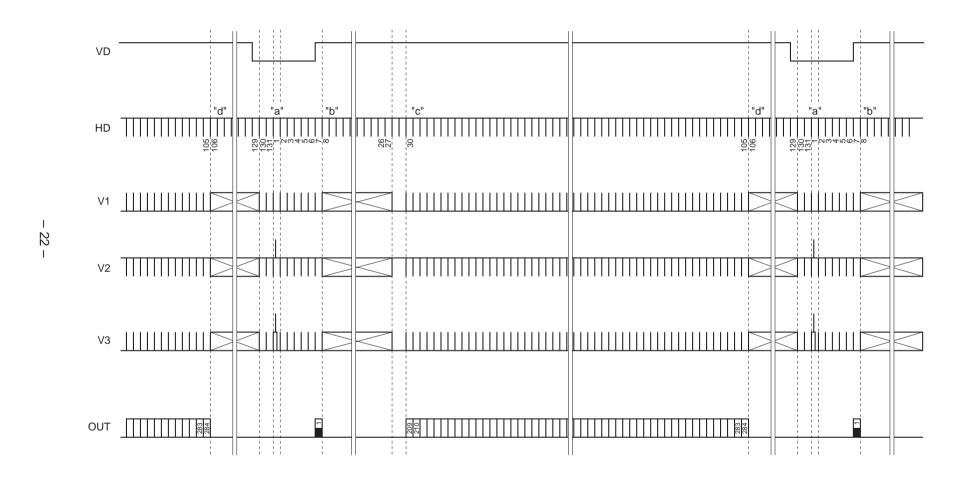


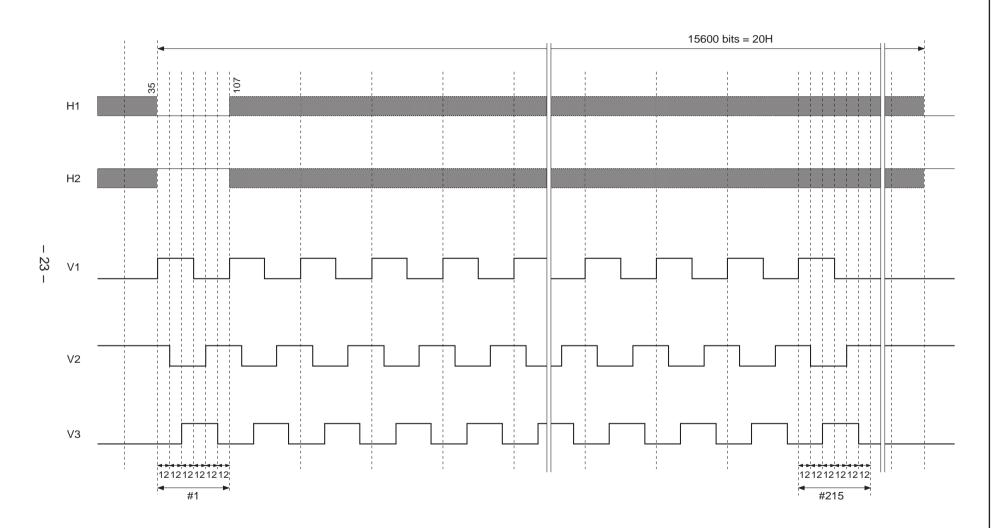


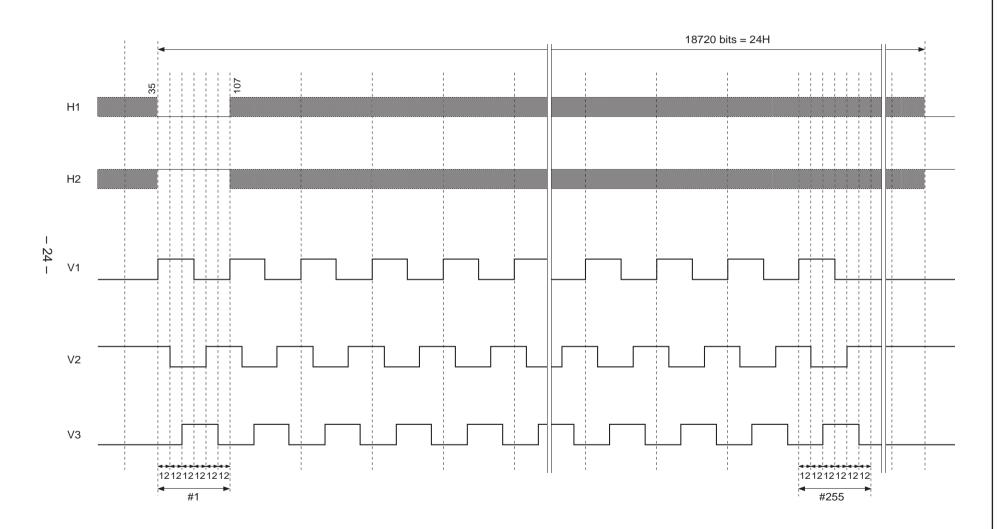


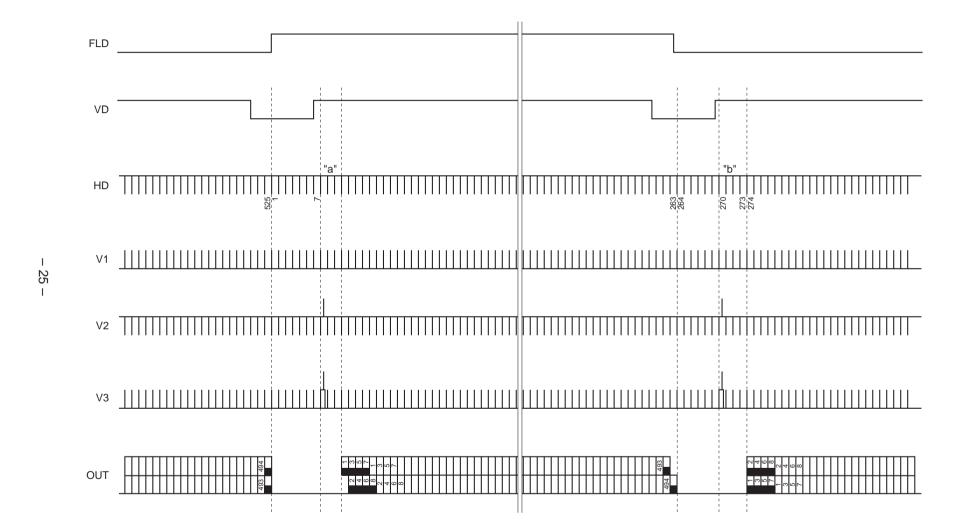


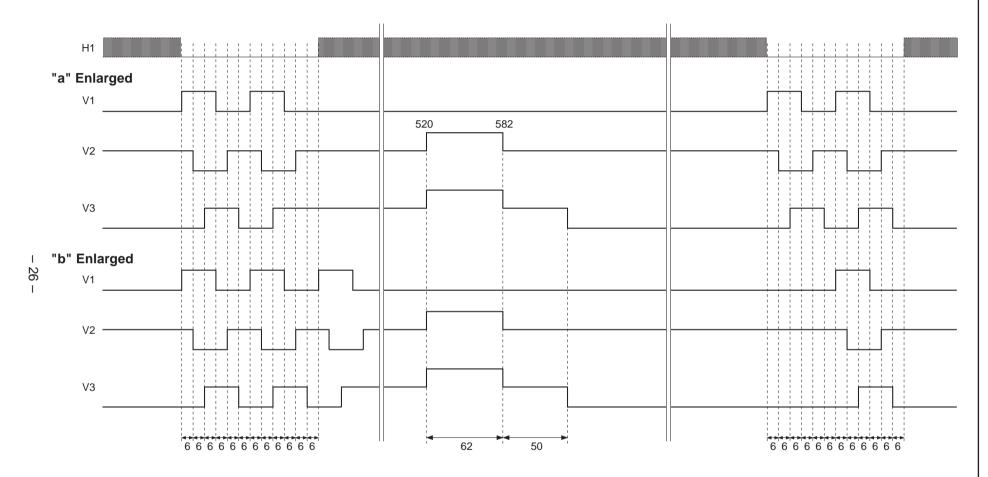


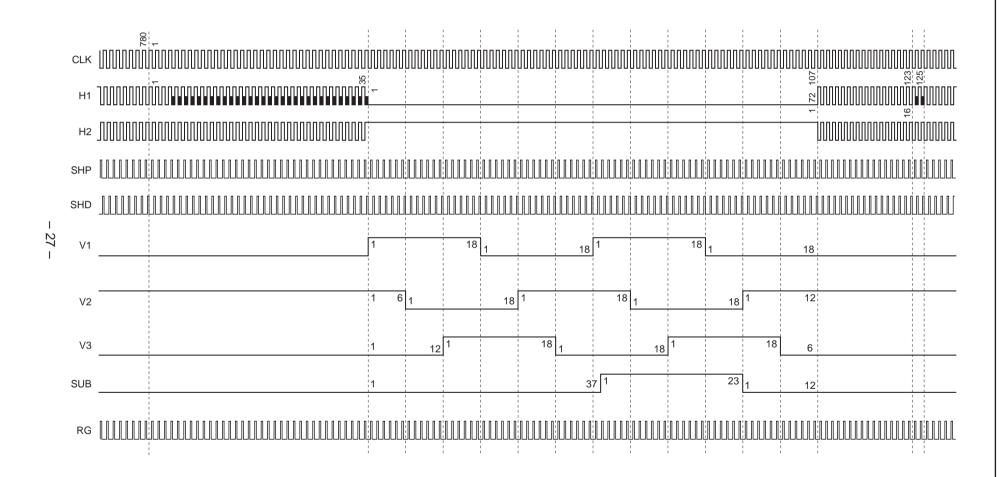












#### **Notes on Handling**

#### 1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

- a) Either handle bare handed or use non-chargeable gloves, clothes or material.
   Also use conductive shoes.
- b) When handling directly use an earth band.
- c) Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- d) Ionized air is recommended for discharge when handling CCD image sensors.
- e) For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

#### 2) Soldering

- a) Make sure the package temperature does not exceed 80°C.
- b) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a 30W soldering iron with a ground wire and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- c) To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero-cross On/Off type and connect it to ground.

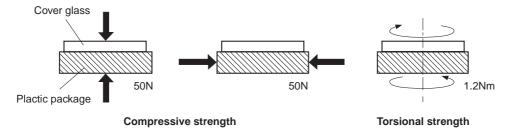
#### 3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operations as required, and use them.

- a) Perform all assembly operations in a clean room (class 1000 or less).
- b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)
- c) Clean with a cotton bud and ethyl alcohol if grease stained. Be careful not to scratch the glass.
- d) Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- e) When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.

#### 4) Installing (attaching)

a) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)

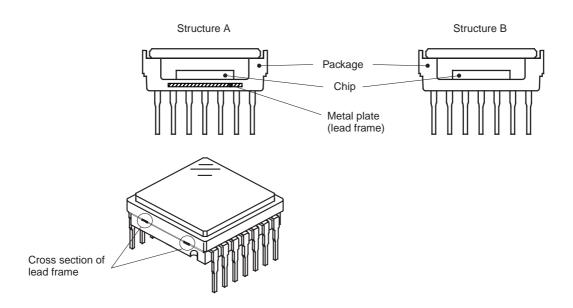


b) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the bottom of the package. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

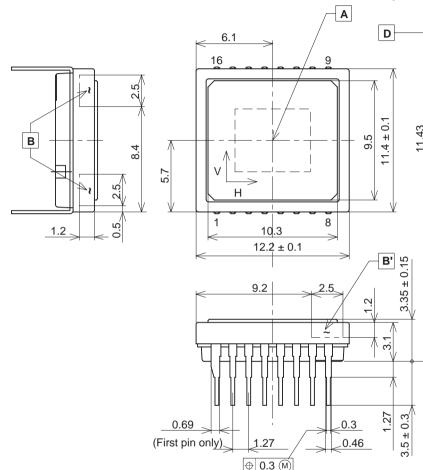
- c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.
- d) The notch of the package is used for directional index, and that can not be used for reference of fixing. In addition, the cover glass and seal resin may overlap with the notch of the package.
- e) If the leads are bent repeatedly and metal, etc., clash or rub against the package, the dust may be generated by the fragments of resin.
- f) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)

### 5) Others

- a) Do not expose to strong light (sun rays) for long periods. For continuous using under cruel condition exceeding the normal using condition, consult our company.
- b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.
- c) Brown stains may be seen on the bottom or side of the package. But this does not affect the CCD characteristics.
- d) This package has 2 kinds internal structure. However, their package outline, optical size, and strength are the same.



The cross section of lead frame can be seen on the side of package for structure A.



Unit: mm

# PACKAGE STRUCTURE

**Package Outline** 

PACKAGE MATERIAL	Plastic
LEAD TREATMENT	GOLD PLATING
LEAD MATERIAL	42 ALLOY
PACKAGE MASS	0.90g
DRAWING NUMBER	AS-C2.2-03(E)

1. "A" is the center of the effective image area.

0.25

2 ô

С

2. The two points "B" of the package are the horizontal reference. The point "B" of the package is the vertical reference.

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- 3. The bottom "C" of the package, and the top of the cover glass "D" are the height reference.
- 4. The center of the effective image area relative to "B" and "B" is  $(H, V) = (6.1, 5.7) \pm 0.15$ mm.
- 5. The rotation angle of the effective image area relative to H and V is  $\pm 1^{\circ}$ .
- 6. The height from the bottom "C" to the effective image area is  $1.41 \pm 0.10$ mm. The height from the top of the cover glass "D" to the effective image area is  $1.94 \pm 0.15$  mm.

11.6

2.5

2-R0.5

- 7. The tilt of the effective image area relative to the bottom "C" is less than 50µm. The tilt of the effective image area relative to the top "D" of the cover glass is less than 50µm.
- 8. The thickness of the cover glass is 0.75mm, and the refractive index is 1.5.
- 9. The notches on the bottom of the package are used only for directional index, they must not be used for reference of fixing.

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